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NAPA-p1: Nanosecond Timing Pixel for Large Area Sensors

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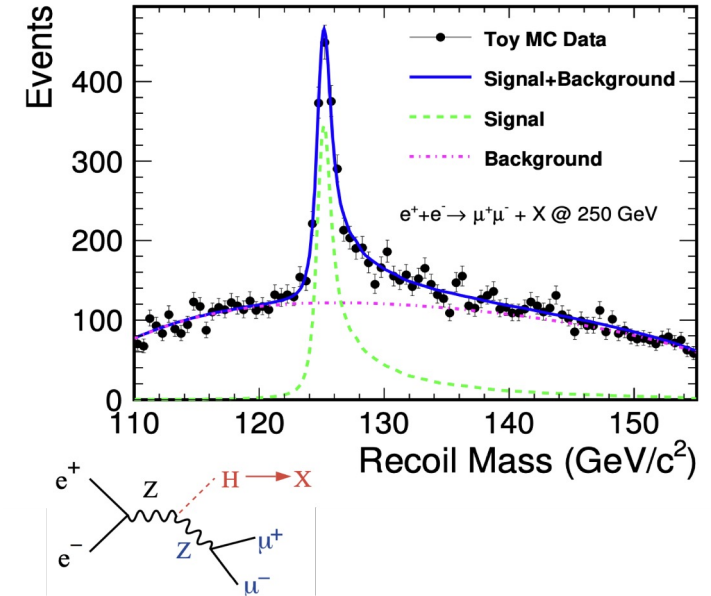
Presentation Outline

- Application: Future e⁺e⁻ Colliders
- Target Specifications Vs State of the Art
- SLAC Development: NAPA_p1
- Going Towards a Large Area Sensor
- Conclusion & Perspectives

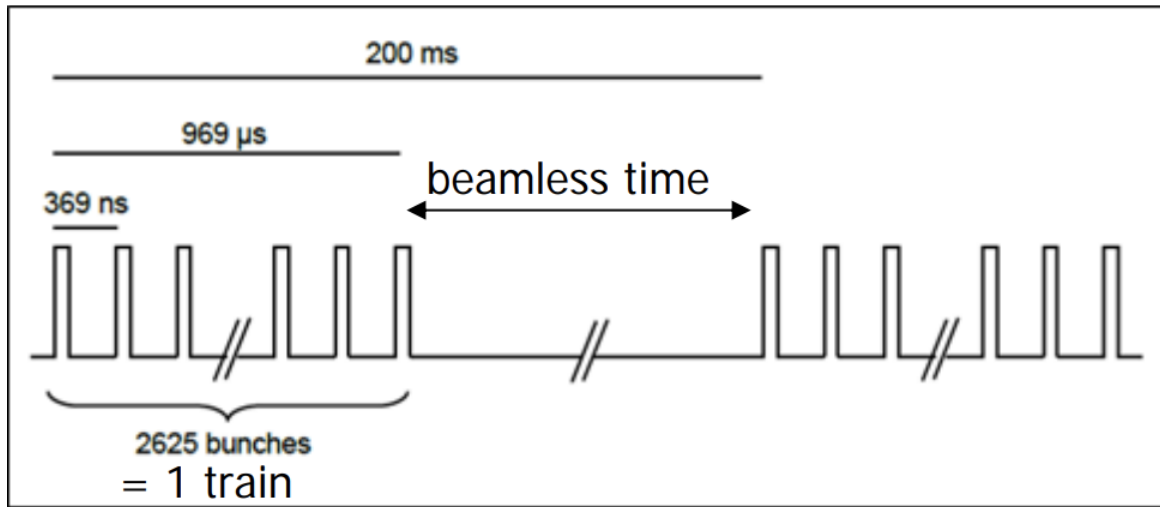
Future Linear e+e- Colliders

Designed to work as Higgs Factory driving the requirements for detectors:

- Material budget $< 0.3\% X_0$
- Gas cooling \rightarrow Very low average power consumption
- Spatial resolution: $5 \mu\text{m}$
- Time-tagging in the order of $O(1\text{ns})$



ILC Timing Structure

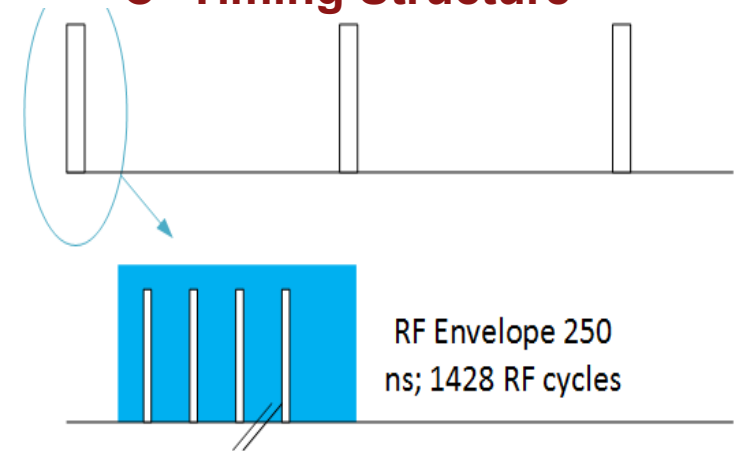


SLAC

Duty Cycle = 0.48%

C³ Timing Structure

Trains repeat at 120 Hz



75 1 nC bunches spaced by 19 RF periods (3.3 ns)

RF Envelope 250 ns; 1428 RF cycles

Duty Cycle = 0.03 %

~ 1 ns time resolution is needed

Specifications from Physics to Pixel

Specification	Physics	Pixel
Input charge	Minimum Ionizing Particle (MIP)	Assuming epitaxial layer of $\sim 10 \mu\text{m}$ MIP goes through pixel center generates $\sim 600 \text{ e-}$ MIP shared between 4 pixels $\rightarrow \sim 150 \text{ e-}$
Noise	Negligible fake hits	Noise $< \frac{\text{Min Input Charge}}{5} \rightarrow \text{ENC} < 30 \text{ e-rms}$
Time resolution	Identity bunches within a train (C^3)	Time resolution $< 1 \text{ ns-rms}$ for whole chain considering : sensor, front-end, time walk, TDC
Average Power Consumption	Gas cooling	Depends on detector total area, used gas, and allowed increased in temperature. Initial estimation to be confirmed 20 mW/cm^2
Spatial resolution	$\sim 5 \mu\text{m}$	Pixel pitch $25 \mu\text{m}$

These initial specifications serve as a baseline for the first prototype developed at SLAC : NAPA-p1

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Target Specs Vs State of the Art

Chip name	Technology	Pixel pitch [μm]	Pixel shape	Time resolution [ns]	Power Density [mW/cm ²]
Target Specification	?	≤ 25 x 100	Sq / rect	1	< 20
ALPIDE ^{[2][3]}	Tower 180 nm	28	Square	< 2000	5
FastPix ^{[4][5]}	Tower 180 nm	10 - 20	Hexagonal	0.122 – 0.135	>1500
DPTS ^[6]	Tower 65 nm	15	Square	6.3	112
Cactus ^[7]	LF 150 nm	1000	Square	0.1-0.5	145
MiniCactus ^[8]	LF 150 nm	1000	Square	0.088	300
Monolith ^{[9][10]}	IHP SiGe 130 nm	100	Hexagonal	0.077 – 0.02	40 - 2700



No design fulfills all target specification →
The need to develop a custom design

We decided to go with the Tower 65nm technology, which has been optimized by CERN WP1.2 to have low sensor capacitance allowing very good performance with low power consumption.

- + it has the possibility of a wafer-scale stitched sensor
- + it has been proven to be radiation tolerant

Tower Semiconductor 65 nm Imaging technology

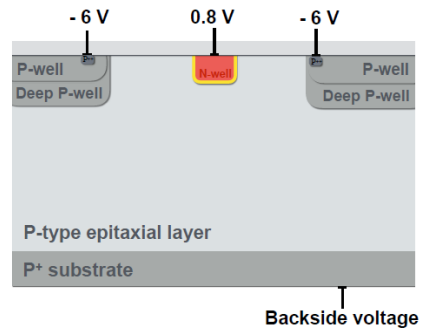
Thanks to CERN WP1.2 effort on sensor optimization in TowerSemi 180 nm and 65 nm technologies [12] [13]

- → C_{sensor} of 2-3 fF is achievable while maintaining high collection efficiency.

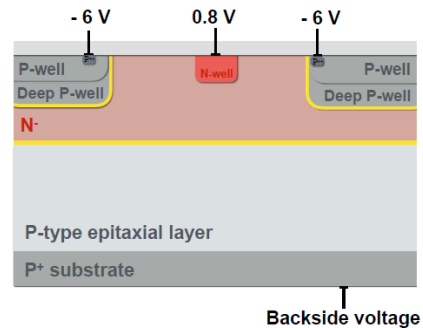
This is very useful from a pixel performance point of view as:

For a constant SNR and Q_{in} → $\text{Power} \propto (C_{\text{sensor}})^m$ with $2 \leq m \leq 4$ as shown in [11]

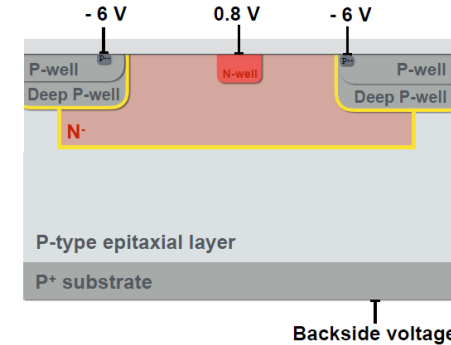
Standard process:



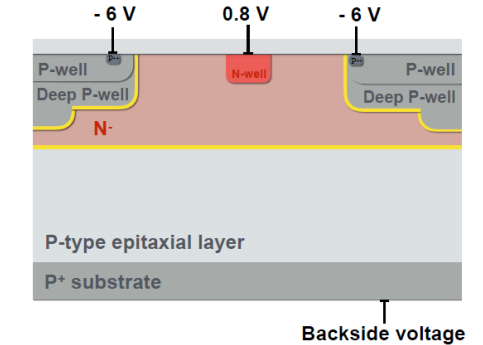
Modified process:



Gap in deep n-implant:



Additional p-implant:



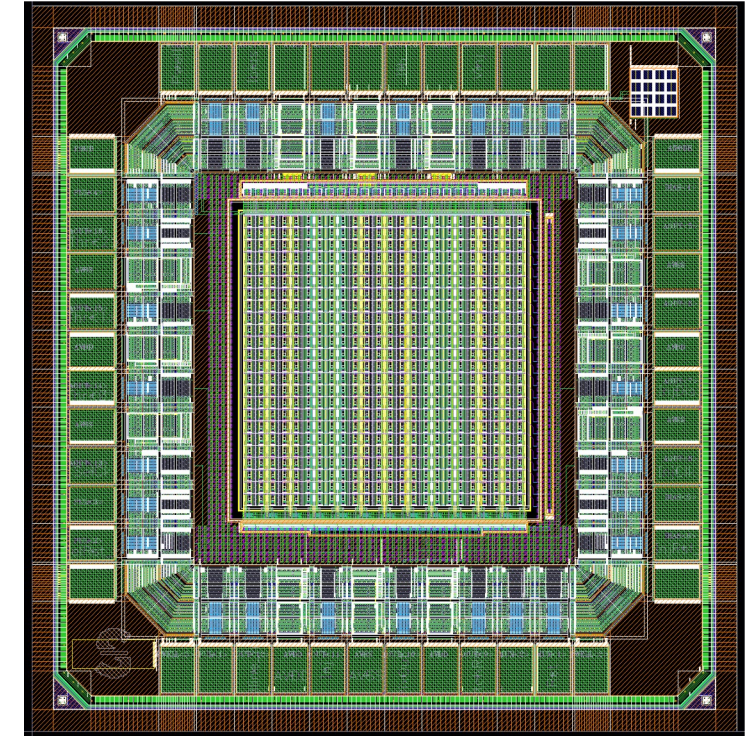
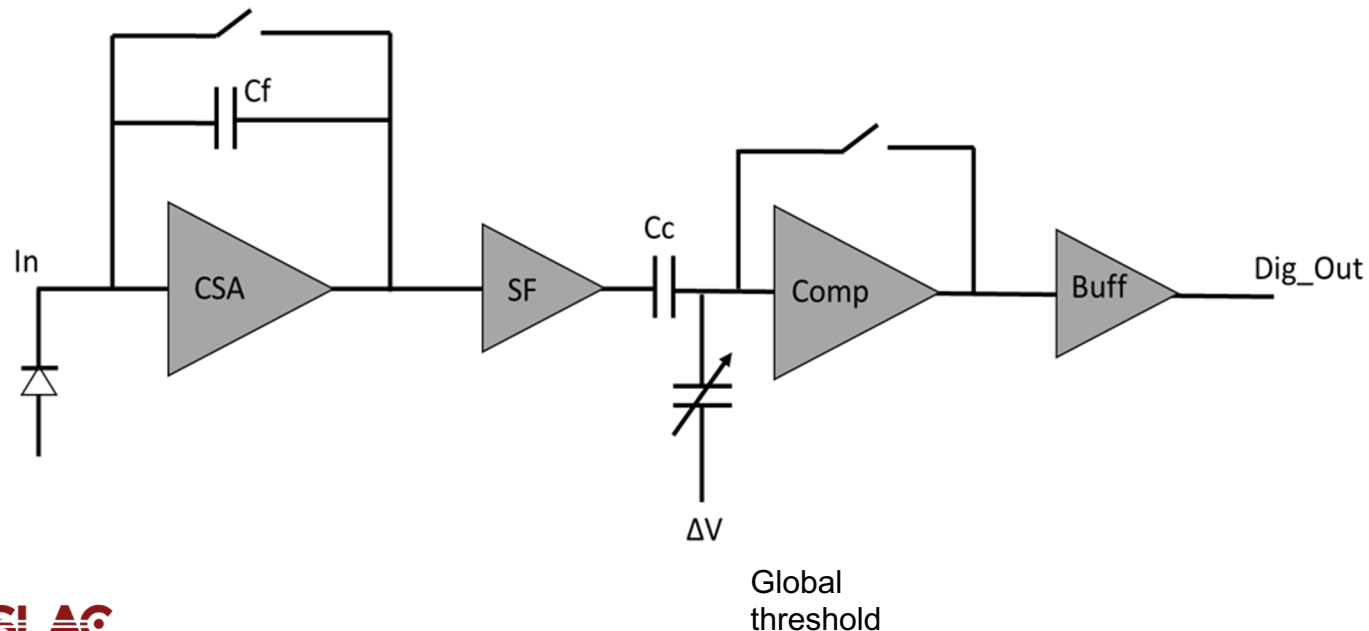
Sensor optimization in TowerSemi 180 nm process from [12] and [13]

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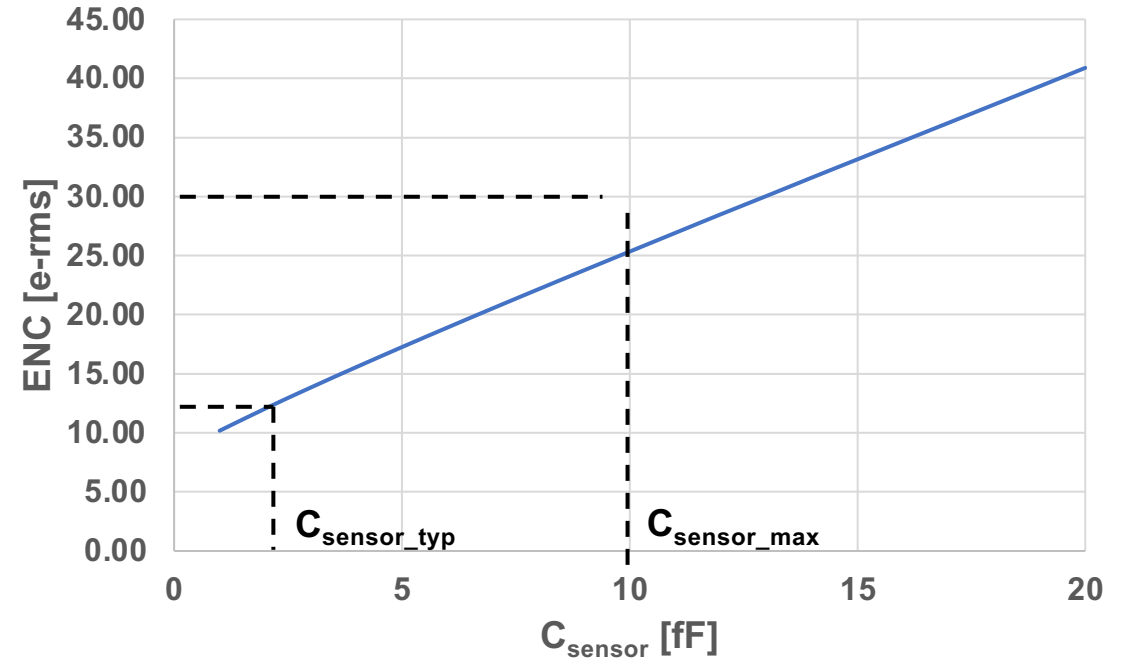
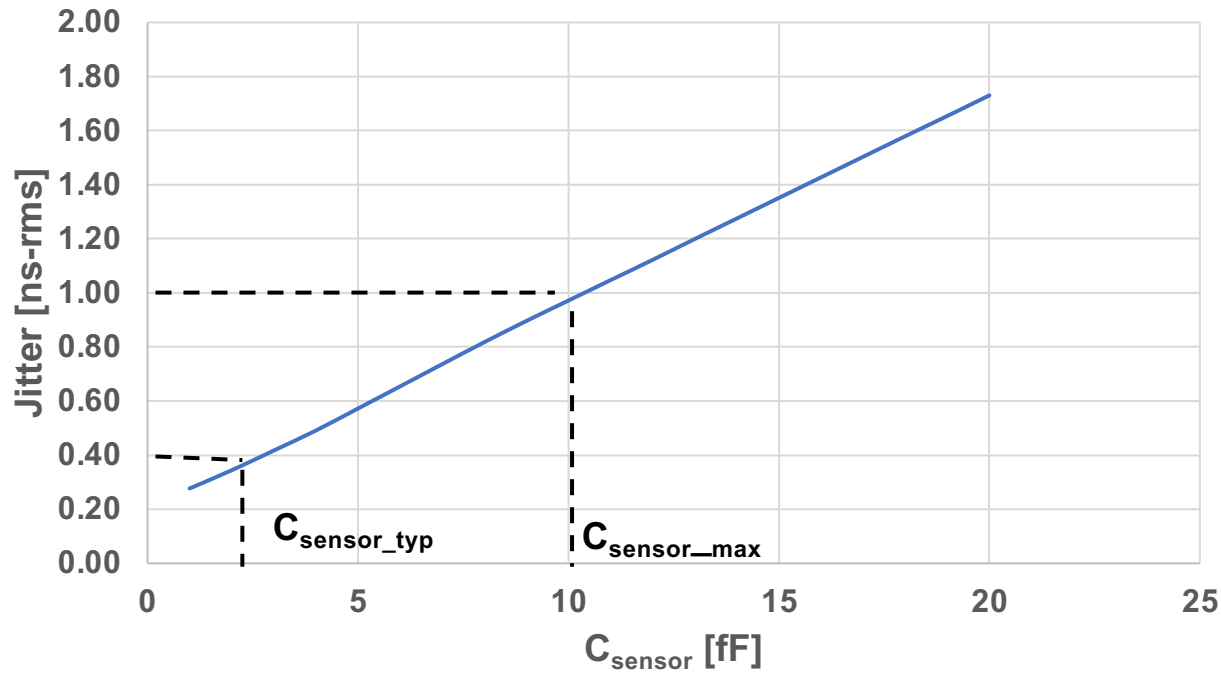
NAPA_p1: NAnosecond Pixel for large Area sensors – Prototype 1

- The prototype design submitted with a total area 5 mm x 5 mm and a pixel of 25 μm x 25 μm , to serve as a baseline for sensor and pixel performance.
- Design motivation \rightarrow Synchronous architecture (known beam time structure), Correlated Double Sampling, eliminating low frequency noise, allowing use of minimum size transistors
- Power pulsing \rightarrow reduce average power consumption by more than 100



Layout of MAPS SLAC prototype for WP1.2 shared submission

Simulation of Jitter and ENC as a Function of C_{sensor}



jitter = 400 ps for $C_{\text{sensor_typ}} \approx 2$ fF

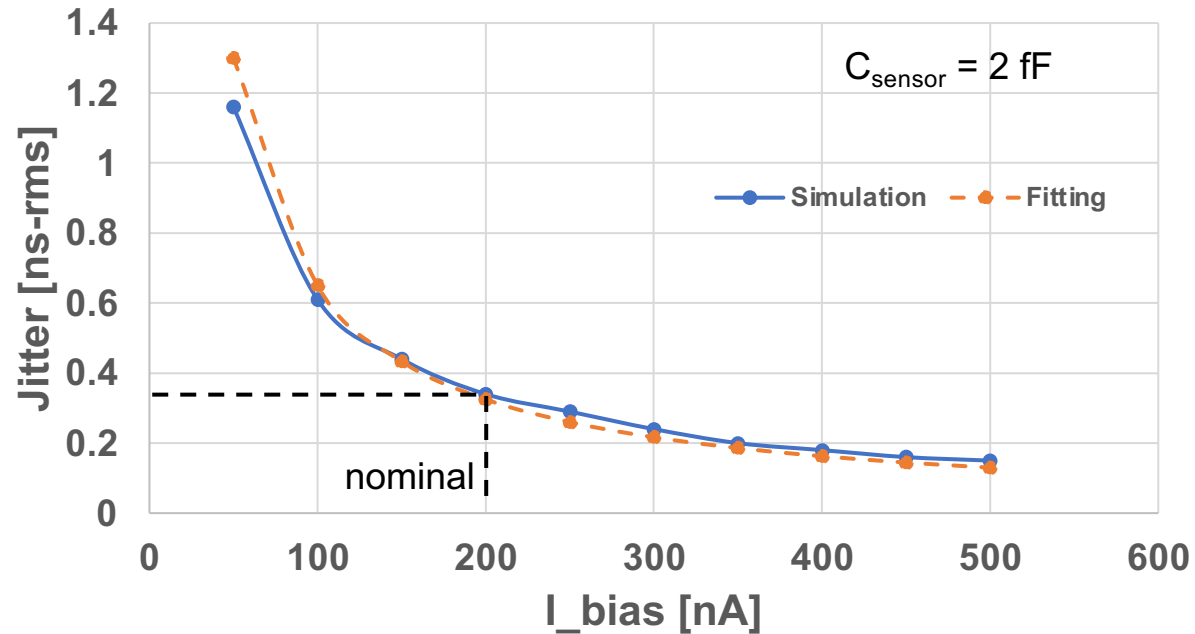
Ok for Specs

ENC = 13 e-rms for $C_{\text{sensor_typ}} \approx 2$ fF

These simulations are with a nominal pixel current of 600 nA \rightarrow <Power density> = 115 mW/cm² x duty cycle
For e+e- machines such as ILC and C³, duty cycle is expected < 1%

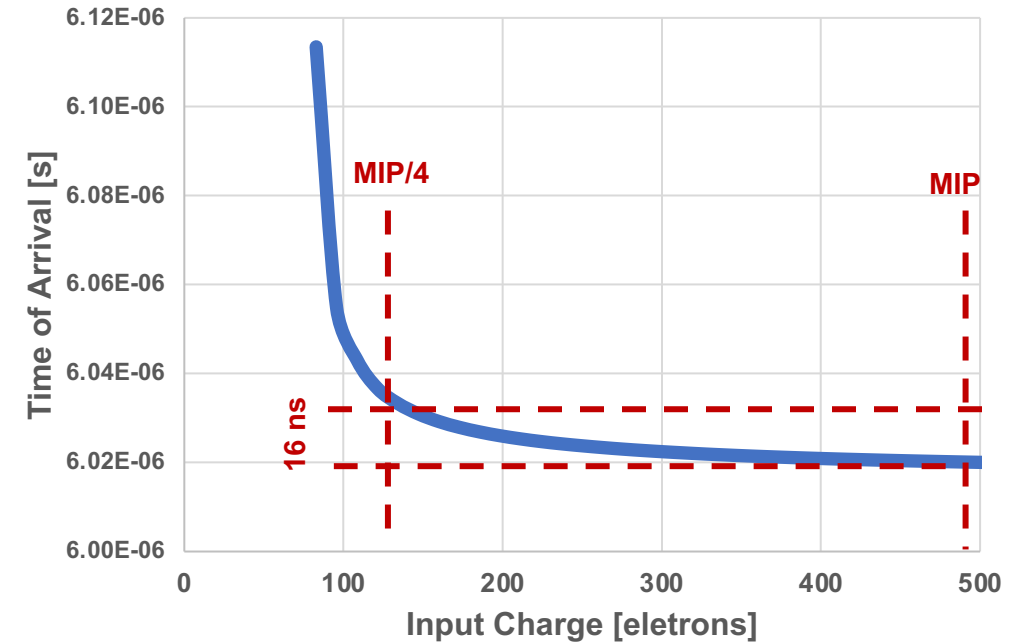
Simulation Results : Jitter and Time Walk

Jitter



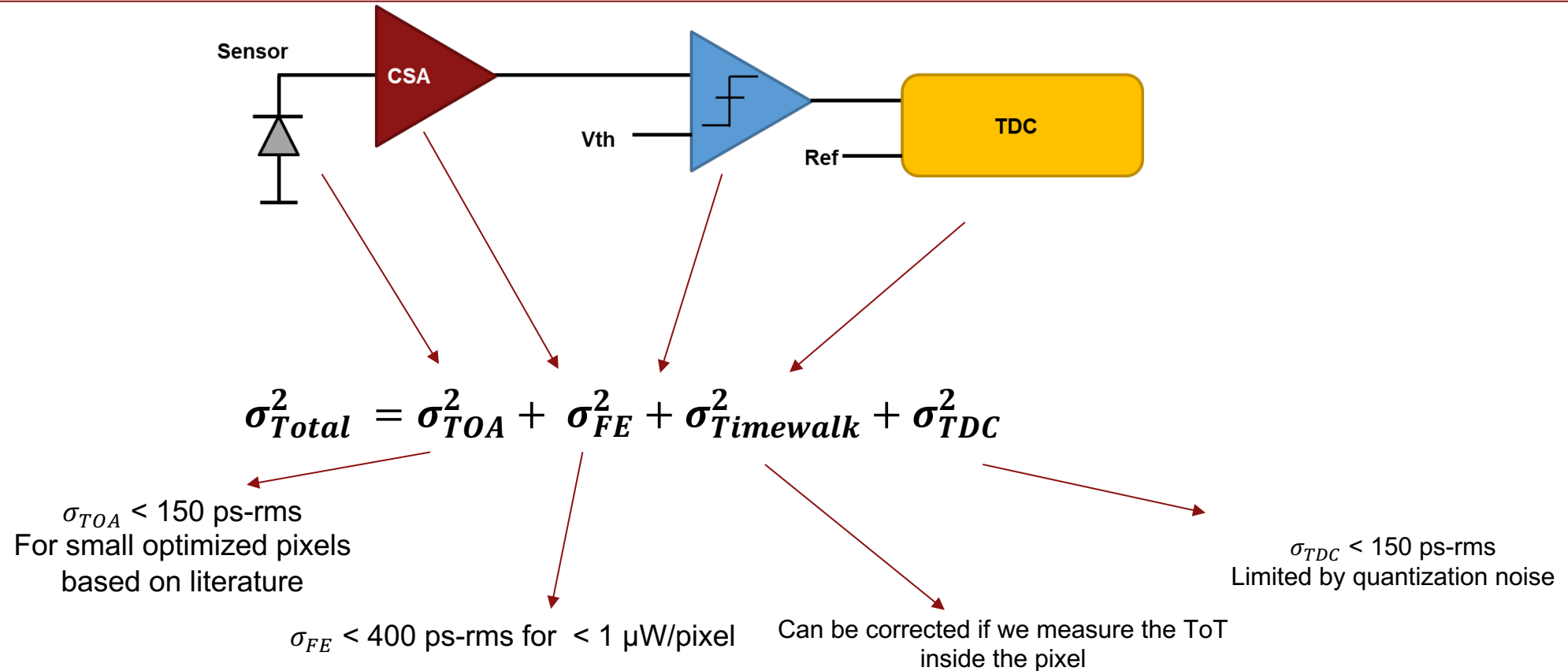
$I_{\text{bias}} = 200 \text{ nA} \equiv \text{pixel current} = 600 \text{ nA}$
From theory we expect : $\sigma_{\text{FE}} \propto \frac{1}{(\text{Power})^{\frac{1}{n}}}$ with $1 \leq n \leq 2$

Time Walk



Time walk for MIP \rightarrow MIP/4 = 16 ns
Not negligible and must be corrected
(in pixel? In balcony? Offline? TBD)

Timing Limits for a Complete Detection Chain

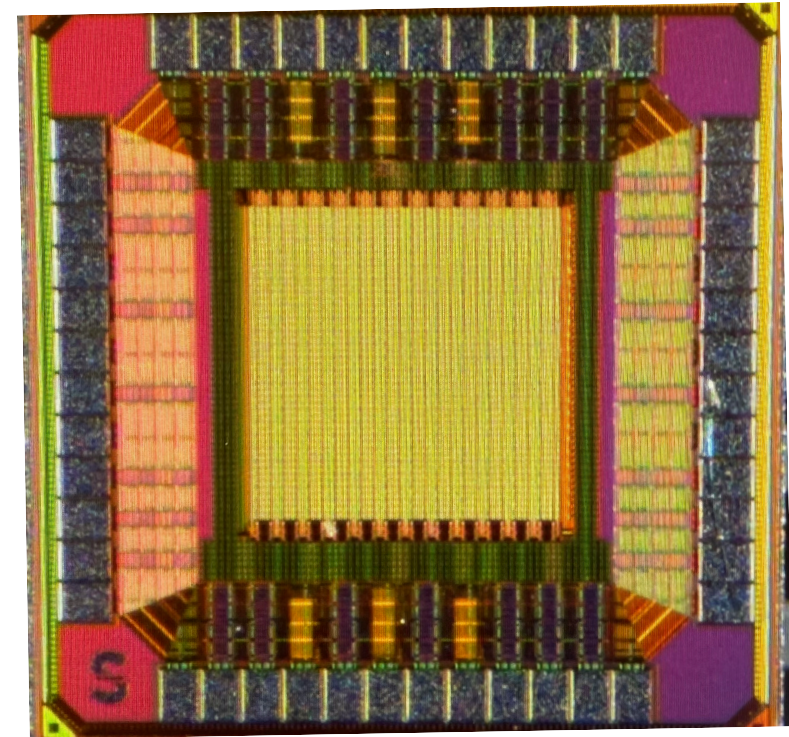


**Assuming time walk is fully corrected $\rightarrow \sigma_{Total} \sim 500$ ps-rms with reasonable pixel power consumption, going lower will cost increasingly more power, not compatible with large area sensors
Accounting for residual time Walk after correction, and other non-idealities, it is reasonable to aim for ~ 1 ns-rms time resolution**

Summary of NAPA-p1 Performance

	Specification	Simulated NAPA-p1
Time resolution	1 ns-rms	0.4 ns-rms ✓
Spatial Resolution	7 μm	7 μm ✓
Noise	< 30 e-rms	13 e-rms ✓
Minimum Threshold	200 e-	~ 80 e- ✓
Average Power density	< 20 mW/cm ²	0.1 mW/cm ² for 1% duty cycle ✓

The chip was received at SLAC in September 2023

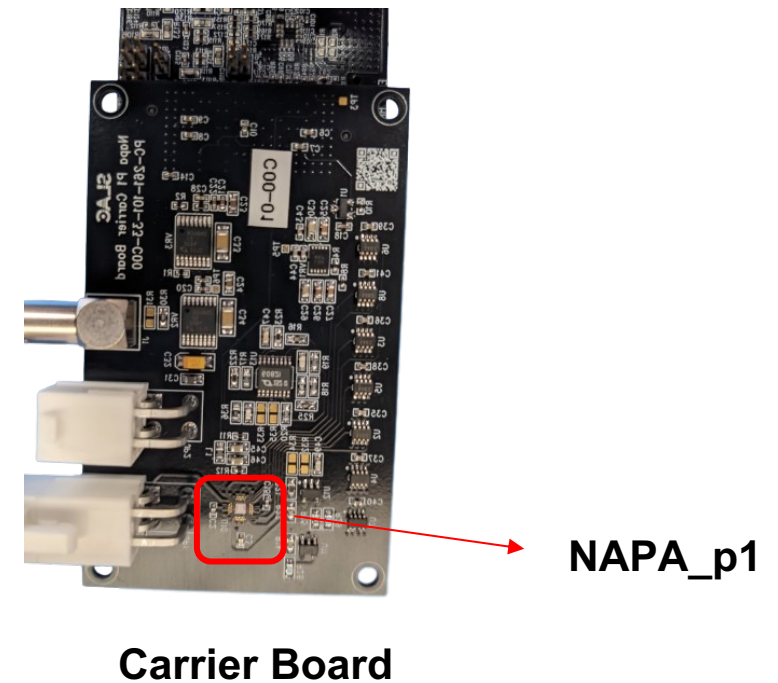
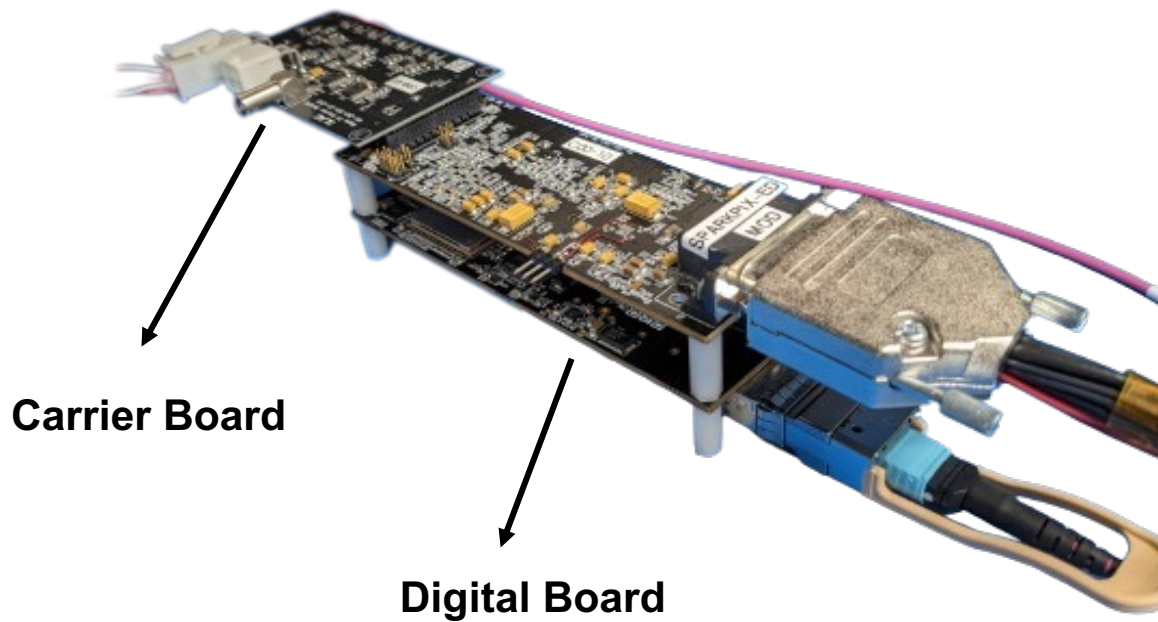


Microscope photo of NAPA-p1

Acknowledgement: to CERN WP 1.2 for the excellent cooperation: NAPA-p1 uses the pixel masked developed and optimized by CERN, and was fabricated in a shared run led by CERN

Test Setup for NAPA-p1

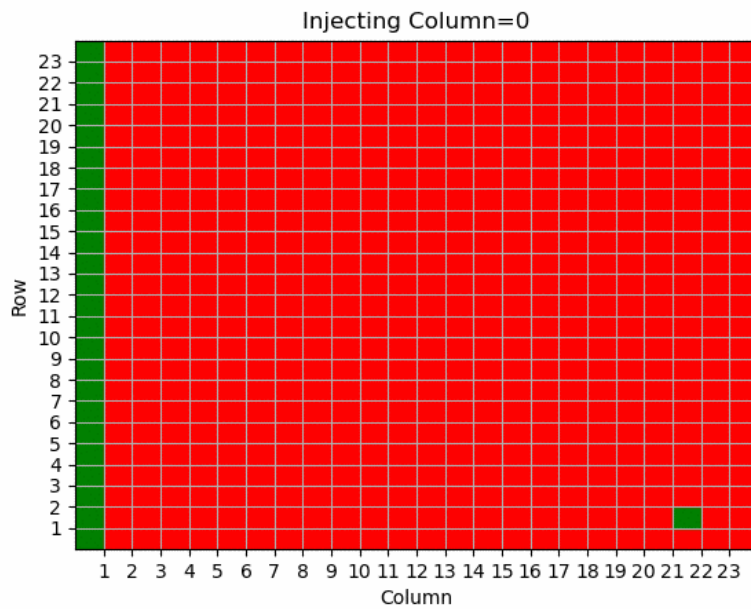
- A custom carrier was designed at SLAC for the NAPA-p1 chip providing all analog references
- The chip was wire-bonded at SLAC
- The carrier board connects to a digital board containing an FPGA and several DAC's



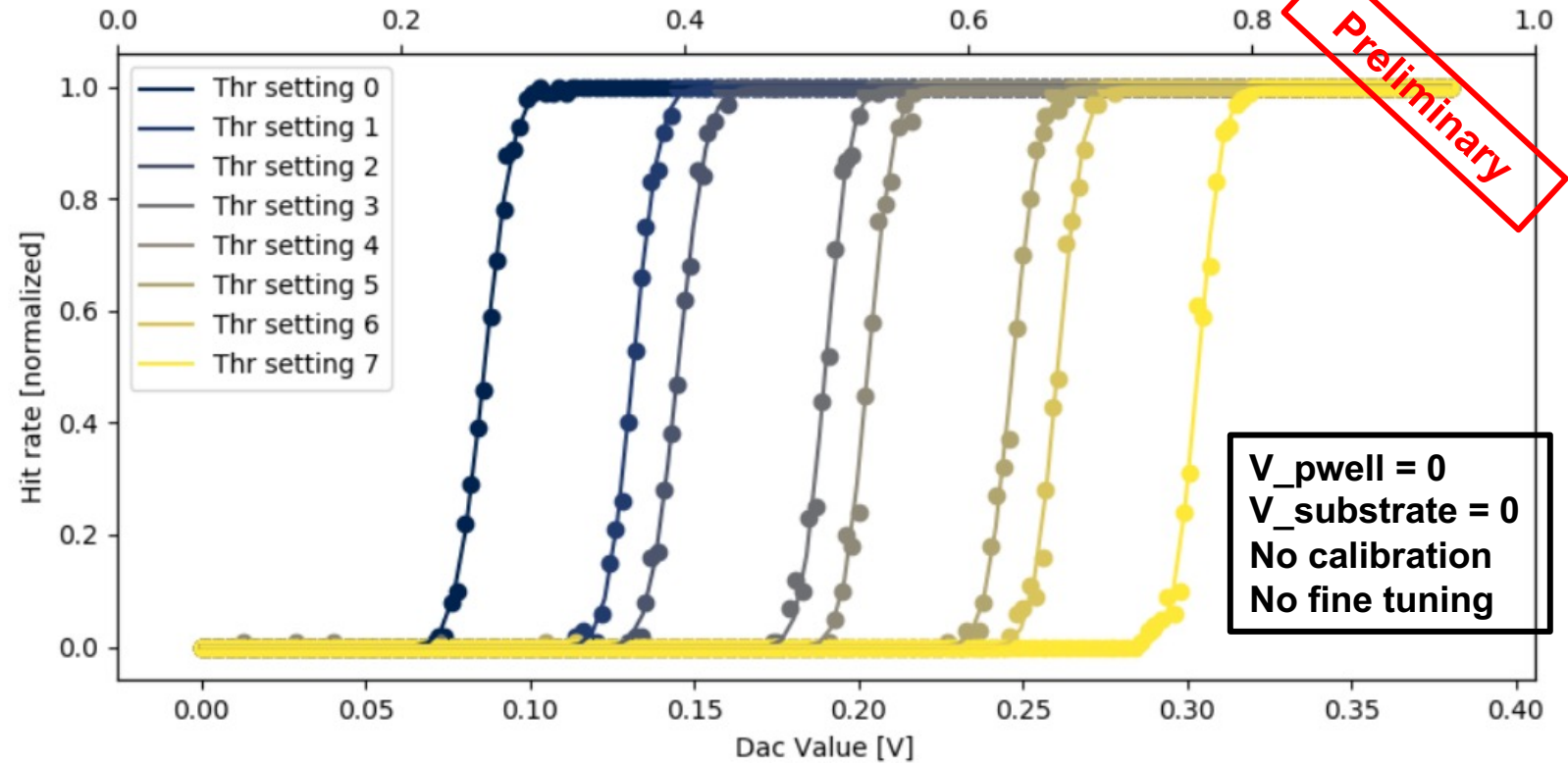
Preliminary Characterization Results

Functional Testing

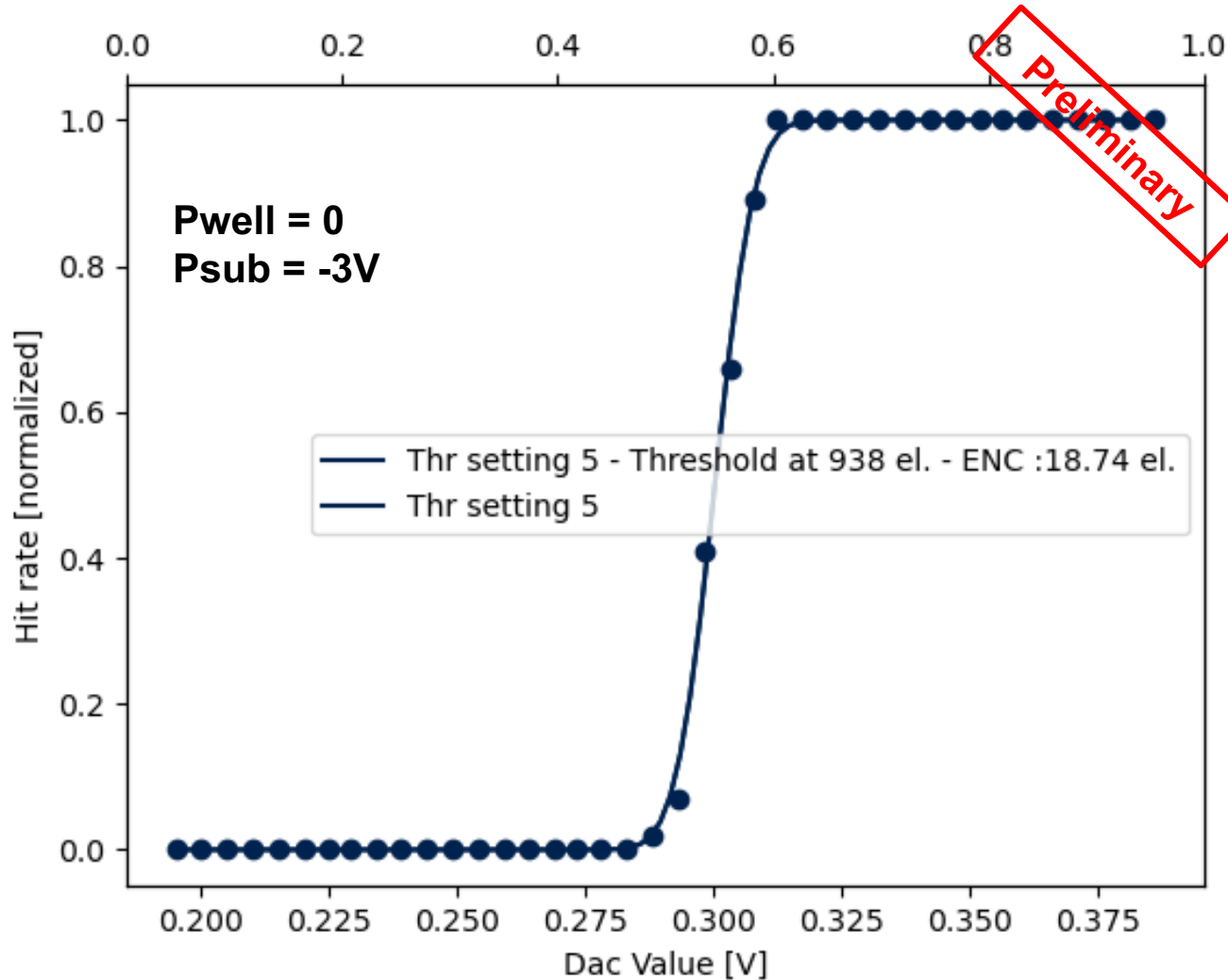
Columns Scan



Injection charge scan across different threshold configuration



ENC measurement



- Injection cap not calibrated yet. A Laser setup is needed for that. Design value is used for C_{inj}
- ENC value is close to simulation ~ 13 e-rms for $C_{sensor} = 2$ fF
- ENC value satisfies the specification < 30 e-rms
- More measurements to be available soon

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Going Towards a Large Sensor → Challenge

$$\Delta V = I_{pix} \times R_{pix} + 2 \times I_{pix} \times R_{pix} + 3I_{pix} \times R_{pix} + \dots + N \times I_{pix} \times R_{pix}$$

$$\Delta V = I_{pix} \times R_{pix} (1 + 2 + 3 + \dots + N)$$

$$\Delta V = I_{pix} \times R_{pix} \times \frac{N(N+1)}{2}$$

Assuming $I_{pix} = 600 \text{ nA}$ and $R_{pix} = 300 \text{ m}\Omega$

Assuming pixel of $25 \mu\text{m} \times 25 \mu\text{m}$

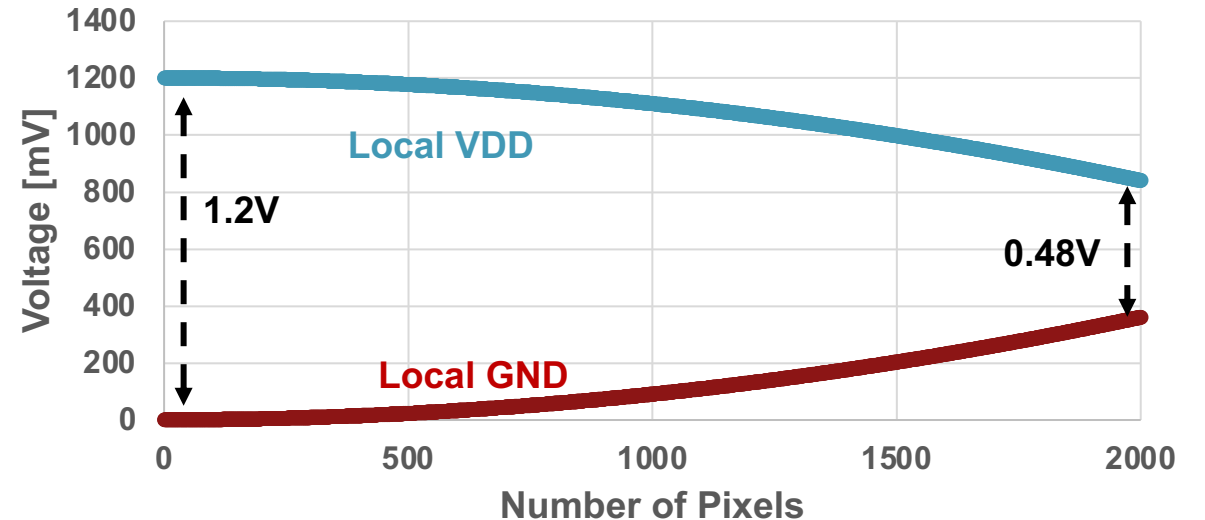
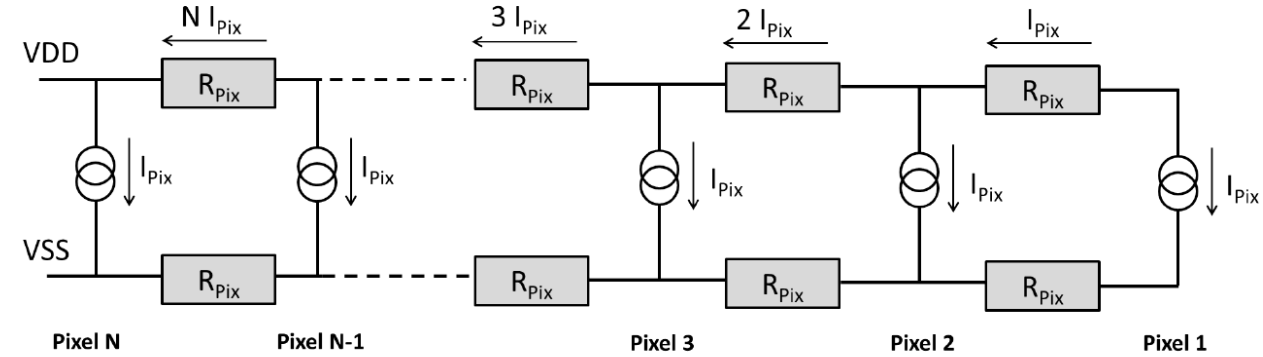
A column of 10 cm would have 4000 pixels

Double sided powering

→ max drop length = 2000 pixels

VDD-GND goes from 1.2 V near the power pads down to around 480 mV after 2000 pixels

The main limitation comes from large scale power distribution rather than cooling constraints

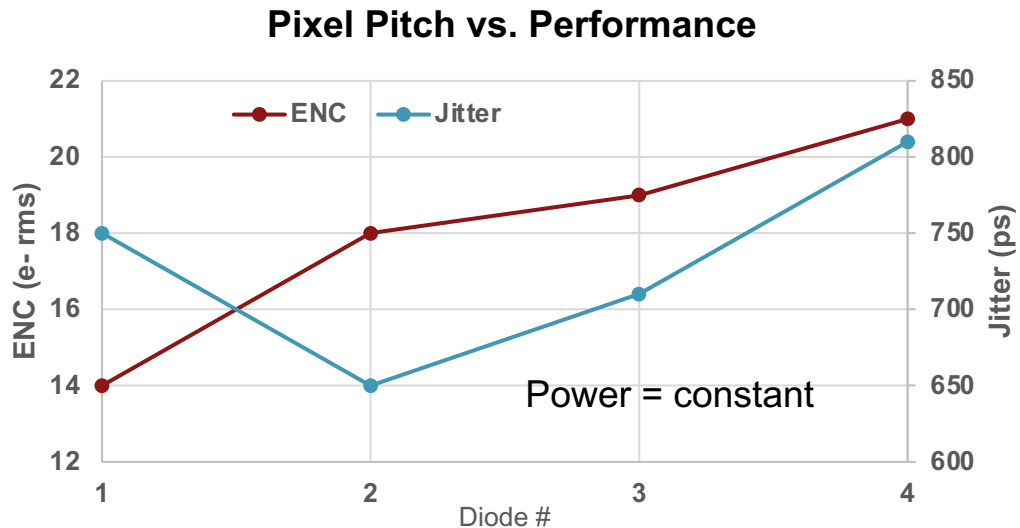


After 10^3 pixels (reticle, 2.5 cm), $V_{drop} \approx 0.1 \text{ V}$
 After 4×10^3 pixels (sensor, 10cm), $V_{drop} = 1.5 \text{ V} !$

Going Towards a Large Sensor → Solutions

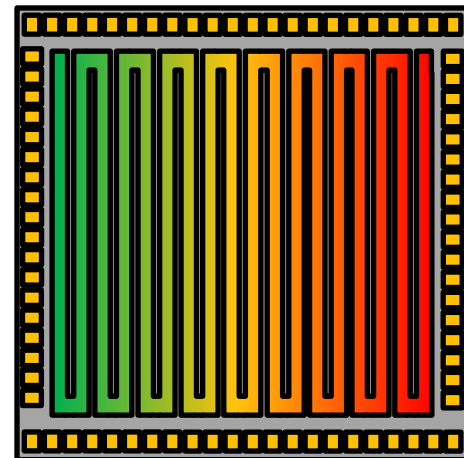
Potential solutions to address the power distribution over a large scale:

1. Decrease power density → Physics requirement are for a pixel of $25\ \mu\text{m} \times 100\ \mu\text{m}$. Our initial study shows that a pixel of $25\ \mu\text{m} \times 50\ \mu\text{m}$ gives the best optimization for $\frac{\text{Performance}}{\text{Power Density}}$
2. Reduce R_{pix} → Redesign of power grid
3. Keep power constant → Switch from a single ended to a differential comparator
4. Reduce the column length → Target sensor of $5\ \text{cm} \times 20\ \text{cm}$ instead of $10\ \text{cm} \times 10\ \text{cm}$
5. Backup plan: develop capless LDO regulator → ongoing shared effort with CERN WP1.2
6. → NAPA-p2 design has started to tackle these challenges



Simulation by
Jacob Sillman

Potential Configuration of NAPA-p2

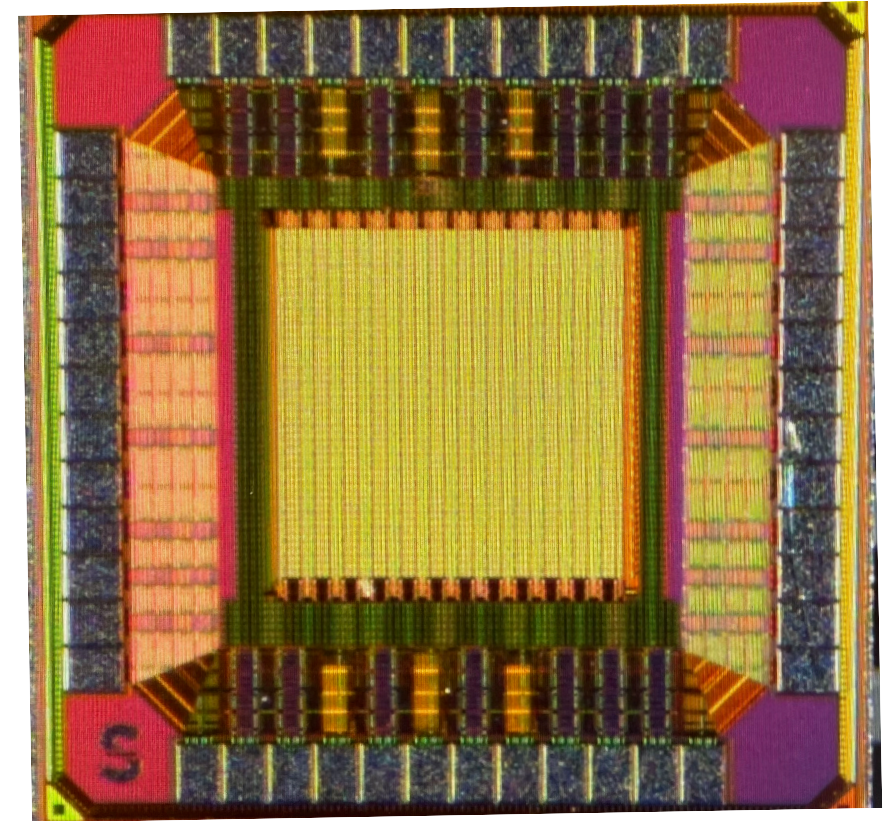


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Conclusion & Perspectives

- MAPS has great a potential to fit the future e+e- colliders requirements (tracker, calorimeter)
- Simulations of NAPA_p1 show that it is possible to achieve a time resolution ~ 1 ns-rms with reasonably low power consumption of ~ 100 mW/cm² \times Duty Cycle. For e+e- machines duty cycles are typically $< 1\%$
- We've just received the NAPA-p1 chip and the first characterization results are promising. NAPA-p1 will serve as a pixel proof of concept.
- Design of NAPA-p2 has started to tackle large sensor challenges. NAPA-p2 will serve as a system proof of concept.
- These prototypes are customized for linear lepton colliders with low duty cycle, however, many of the developed technical solutions can be of value to other applications (large area stitched sensor with increased yield, power distribution, IP blocks (capless LDO regulator, TDC,...))



Microscope photo of NAPA-p1

References

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- [4] T. Kugathasan *et al.*, “Monolithic CMOS sensors for sub-nanosecond timing”, Nuclear Instruments and Methods in Physics Research, Volume 979, 2020, <https://doi.org/10.1016/j.nima.2020.164461>.
- [5] J. Braach *et al.*, “Performance of the FASTPIX Sub-Nanosecond CMOS Pixel Sensor Demonstrator”, *Instruments* 2022, 6(1), 13; <https://doi.org/10.3390/instruments6010013>
- [6] G.A. Rinella *et al.* “Digital Pixel Test Structures implemented in a 65 nm CMOS process” <https://doi.org/10.48550/arXiv.2212.08621>
- [7] Y. Degerli *et al* 2020 *JINST* 15 P06011 DOI 10.1088/1748-0221/15/06/P06011
- [8] Y. Degerli *et al.*, “MiniCACTUS: Sub-100 ps timing with depleted MAPS”, Nuclear Instruments and Methods in Physics Research, Volume 1039, 2022, <https://doi.org/10.1016/j.nima.2022.167022>.
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- [11] W. Snoeys, *Monolithic Pixel Detectors for High Energy Physics*, Nuclear Instruments and Methods in Physics Research A 731 (2013) 125–130
- [12] M. van Rijnbach *et al.*, *Radiation hardness and timing performance in MALTA monolithic pixel sensors in TowerJazz 180 nm*, 2022 *JINST* C04034
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